Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/739,149	ICHIKAWA ET AL.	
Examiner	Art Unit	
Theresa Trieu	3748	

			
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Class	Subclass	Date	Examiner
418	145-147, 112,113, 116	12/1/2005	π
418	119-121	12/1/2005	П

INI	INTERFERENCE SEARCHED				
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